Power MOSFET

30 V, 147 A, Single N-Channel, SO-8 FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

• CPU Power Delivery, DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parai	neter		Symbol	Value	Unit
Drain-to-Source Voltage				30	V
			V _{DSS} V _{GS}		V
Gate-to-Source Voltage				±20	
Continuous Drain Current R _{B.IA}		T _A = 25°C	I _D	29.1	Α
(Note 1)		T _A = 100°C		18.4	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.72	W
Continuous Drain		T _A = 25°C	I _D	47.5	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 100°C	1	30.0	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	7.23	W
Continuous Drain	State	T _A = 25°C	I _D	17.1	Α
Current $R_{\theta JA}$ (Note 2)		T _A = 100°C		10.8	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.93	W
Continuous Drain		T _C = 25°C	I _D	147	Α
Current R _{θJC} (Note 1)		T _C =100°C		93	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	69.44	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t _p = 10 μs	I _{DM}	442	Α
Current Limited by Pac	kage	T _A = 25°C	I _{Dmax}	100	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			I _S	68	Α
Drain to Source DV/DT			dV/d _t	6	V/ns
Single Pulse Drain-to-Source Avalanche Energy T_J = 25°C, V_{DD} = 24 V, V_{GS} = 10 V, I_L = 37 A_{pk} , L = 0.3 mH, R_G = 25 Ω			E _{AS}	162.5	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

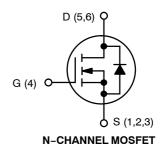
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



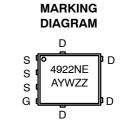
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	2.0 mΩ @ 10 V	4.47.0
30 V	3.0 mΩ @ 4.5 V	147 A







A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4922NET1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.8	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46.0	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	134.2	°C/W
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	17.3	
Junction-to-Top	$R_{ heta JT}$	8.0	

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•	•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				15.2		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			1.0	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = V_{DS}$	= 250 μΑ	1.2	1.6	2.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		1.45	2.0	
			I _D = 15 A		1.45		
		V _{GS} = 4.5 V	I _D = 30 A		2.2	3.0	mΩ
			I _D = 15 A		2.2		1
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			80		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE				•	•	
Input Capacitance	C _{ISS}				5505		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			2355		pF
Reverse Transfer Capacitance	C _{RSS}				90		
Total Gate Charge	Q _{G(TOT)}				34		
Threshold Gate Charge	Q _{G(TH)}	.,	5./ L 00.4		3.8		1
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			13.9		nC
Gate-to-Drain Charge	Q_{GD}				8.1		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			76.5		nC
SWITCHING CHARACTERISTICS (Note 6)					•	•	
Turn-On Delay Time	t _{d(ON)}				20.0		
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			36.2		
Turn-Off Delay Time	t _{d(OFF)}				39.3		ns
Fall Time	t _f				9.4		1

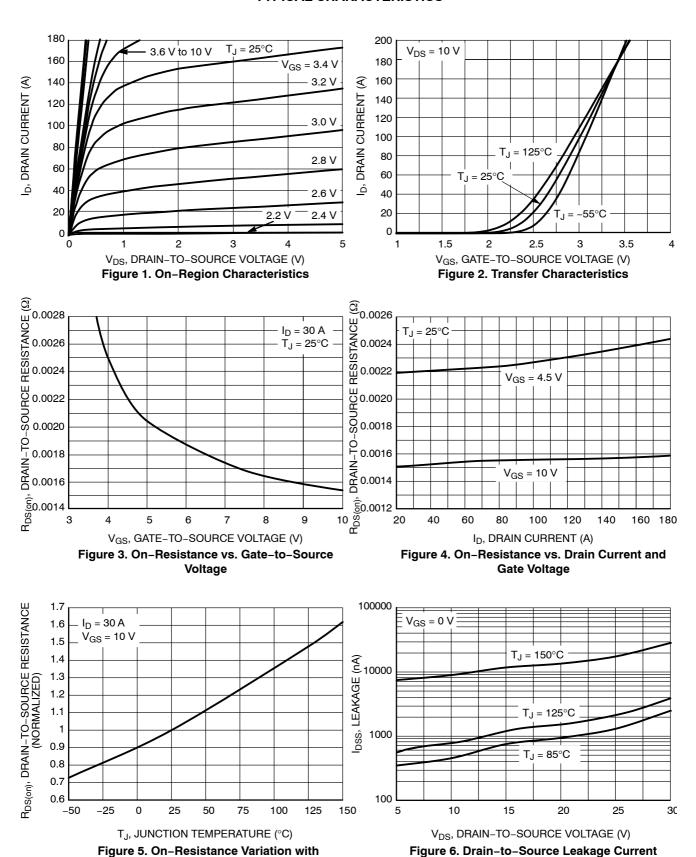
- 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)	•			•		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			13.2		ns
Rise Time	t _r				33.3		
Turn-Off Delay Time	t _{d(OFF)}				49.7		
Fall Time	t _f				7.8		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	VGS = 0 V,	T _J = 25°C		0.79	1.0	V
			T _J = 125°C		0.65		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			59.1		ns
Charge Time	ta				28.3		
Discharge Time	t _b				30.8		
Reverse Recovery Charge	Q_{RR}				70		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				1.00		nΗ
Drain Inductance	L _D	T _A = 25°C			0.005		nΗ
Gate Inductance	L _G				1.84		nH
Gate Resistance	R_{G}				0.55		Ω

^{5.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

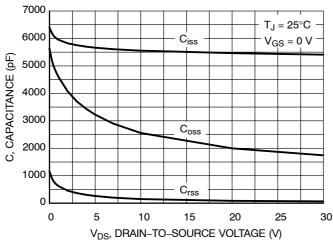


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vs. Voltage

Temperature

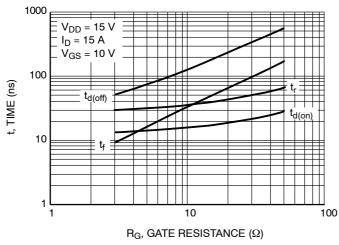
TYPICAL CHARACTERISTICS



V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Qт 9 8 7 6 5 $T_J = 25^{\circ}C$ Q_{GP} Q_{GS} 3 $V_{DD} = 15 V$ 2 $V_{GS} = 10 V$ $I_{D} = 30 A$ 0 0 10 30 40 50 60 70 QG, TOTAL GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



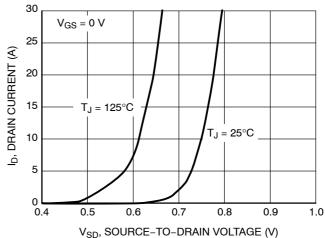
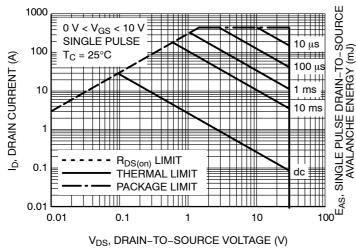


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



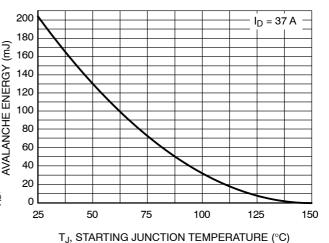


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

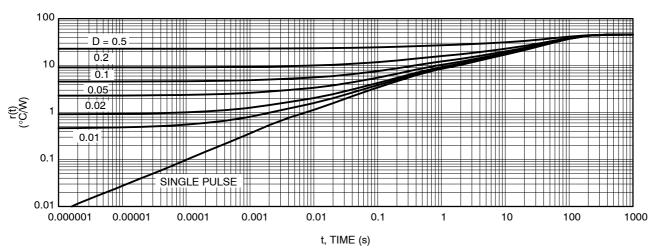


Figure 13. Thermal Response

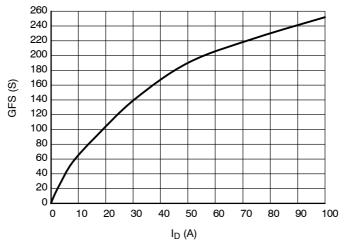


Figure 14. GFS vs. I_D



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	;		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
A	0 0		12 °		

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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